

# MOSFET – Power, Single, P-Channel

-40 V, 13.8 mΩ, -49 A

# NVTFS014P04M8L

#### **Features**

- Small Footprint (3.3 x 3.3 mm) for Compact Design
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- NVTFWS014P04M8L Wettable Flanks Product
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb–Free, Halogen Free/BFR–Free and are RoHS Compliant

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

| Parar   | Symbol           | Value                      | Unit                              |                |    |
|---|------------------|----------------------------|-----------------------------------|----------------|----|
| Drain-to-Source Voltag  | $V_{DSS}$        | -40                        | V                                 |                |    |
| Gate-to-Source Voltage  | €                |                            | $V_{GS}$                          | ±20            | V  |
| Continuous Drain  |                  | $T_C = 25^{\circ}C$        | I <sub>D</sub>                    | -49            | Α  |
| Current R <sub>θJC</sub> (Notes 1, 2, 4)                        | Steady           | T <sub>C</sub> = 100°C     |                                   | -35            |    |
| Power Dissipation   | State            | $T_C = 25^{\circ}C$        | $P_{D}$                           | 61             | W  |
| R <sub>θJC</sub> (Notes 1, 2)                                   |                  | T <sub>C</sub> = 100°C     |                                   | 30             |    |
| Continuous Drain<br>Current R <sub>e.IA</sub>                   |                  | T <sub>A</sub> = 25°C      | I <sub>D</sub>                    | -11.3          | Α  |
| (Notes 1, 3, 4)   | Steady           | T <sub>A</sub> = 100°C     |                                   | -8             |    |
| Power Dissipation   | State            | T <sub>A</sub> = 25°C      | $P_{D}$                           | 3.2            | W  |
| R <sub>θJA</sub> (Notes 1, 3)                                   |                  | T <sub>A</sub> = 100°C     |                                   | 1.6            |    |
| Pulsed Drain Current  | $T_A = 25^\circ$ | °C, t <sub>p</sub> = 10 μs | I <sub>DM</sub>                   | 224            | Α  |
| Operating Junction and Range                                    | Storage T        | emperature                 | T <sub>J</sub> , T <sub>stg</sub> | -55 to<br>+175 | °C |
| Source Current (Body D  | I <sub>S</sub>   | -50                        | Α                                 |                |    |
| Single Pulse Drain-to-S<br>Energy (I <sub>L(pk)</sub> = -6.1 A) | E <sub>AS</sub>  | 143                        | mJ                                |                |    |
| Lead Temperature for S (1/8" from case for 10 s)                |                  | urposes                    | TL                                | 260            | °C |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

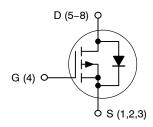
#### THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

| Parameter   | Symbol          | Value | Unit |
|---|-----------------|-------|------|
| Junction-to-Case - Steady State (Drain) (Notes 1, 2, 4) | $R_{\theta JC}$ | 2.5   | °C/W |
| Junction-to-Ambient - Steady State (Note 3)             | $R_{\theta JA}$ | 47    |      |

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- Assumes heat-sink sufficiently large to maintain constant case temperature independent of device power.
- 3. Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.
- Continuous DC current rating. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

| V <sub>(BR)DSS</sub> | R <sub>DS(on)</sub> MAX | I <sub>D</sub> MAX |
|----------------------|-------------------------|--------------------|
| -40 V                | 13.8 mΩ @ –10 V         | -49 A              |
|                      | 18.7 mΩ @ –4.5 V        | -49 A              |

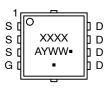
#### P-Channel MOSFET



### MARKING DIAGRAMS



WDFN8 (μ8FL) CASE 511AB





WDFNW8 (Full-Cut m8FL WF) CASE 515AN



XXXX = Specific Device Code A = Assembly Location

Y = Year
WW = Work Week
Pb-Free Package

(Note: Microdot may be in either location)

#### **ORDERING INFORMATION**

See detailed ordering, marking and shipping information on page 5 of this data sheet.

# **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

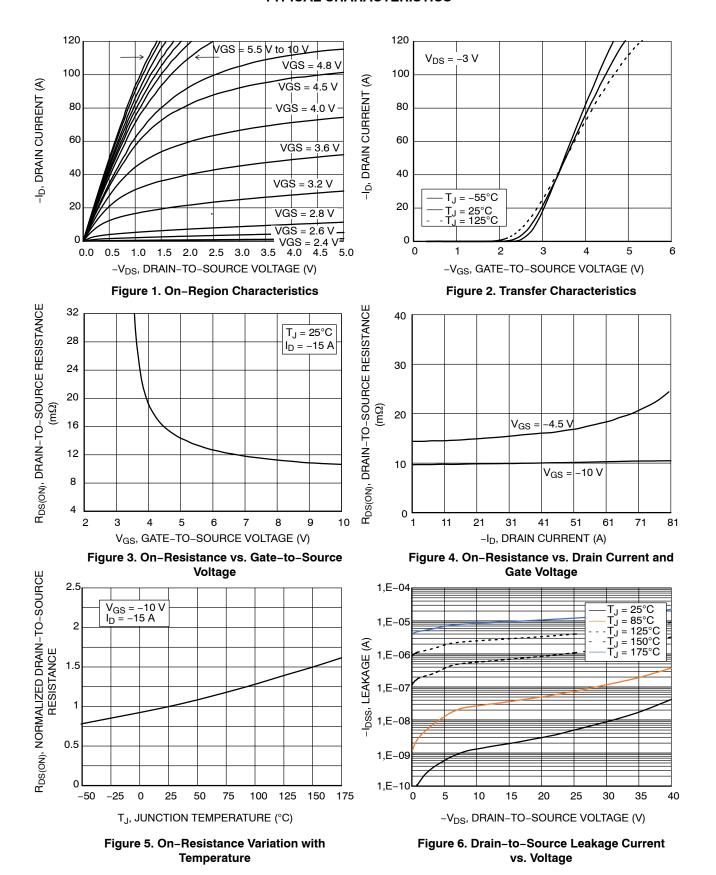
| Parameter  | Symbol                               | Test Cond   | ition                                       | Min  | Тур   | Max           | Unit  |
|--|--------------------------------------|---|---|------|-------|---------------|-------|
| OFF CHARACTERISTICS  |                                      |   |   |      |       | •             |       |
| Drain-to-Source Breakdown Voltage                            | V <sub>(BR)DSS</sub>                 | V <sub>GS</sub> = 0 V, I <sub>D</sub> =                               | -250 μΑ                                     | -40  |       |               | V     |
| Drain-to-Source Breakdown Voltage<br>Temperature Coefficient | V <sub>(BR)DSS</sub> /T <sub>J</sub> |   |   |      | 21    |               | mV/°C |
| Zero Gate Voltage Drain Current                              | I <sub>DSS</sub>                     | V <sub>GS</sub> = 0 V,<br>V <sub>DS</sub> = -40 V                     | $T_J = 25^{\circ}C$<br>$T_J = 125^{\circ}C$ |      |       | -1.0<br>-1000 | μΑ    |
| Gate-to-Source Leakage Current                               | I <sub>GSS</sub>                     | V <sub>DS</sub> = 0 V, V <sub>GS</sub>                                |   |      |       | ±100          | nA    |
| ON CHARACTERISTICS (Note 5)                                  |                                      |   |   |      | 1     |               |       |
| Gate Threshold Voltage                                       | V <sub>GS(TH)</sub>                  | V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> =                  | 420 μA                                      | -1.0 |       | -2.4          | V     |
| Negative Threshold Temperature Coefficient                   | V <sub>GS(TH)</sub> /T <sub>J</sub>  |   |   |      | 5.1   |               | mV/°C |
| Drain-to-Source On Resistance                                | R <sub>DS(on)</sub>                  | V <sub>GS</sub> = -10 V, I <sub>I</sub>                               | <sub>O</sub> = -15 A                        |      | 10    | 13.8          | mΩ    |
|  |                                      | V <sub>GS</sub> = -4.5 V, I <sub>[</sub>                              | <sub>O</sub> = -7.5 A                       |      | 14.6  | 18.7          |       |
| Forward Transconductance                                     | 9FS                                  | V <sub>DS</sub> = -1.5 V, I   | <sub>O</sub> = -15 A                        |      | 42    |               | S     |
| CHARGES AND CAPACITANCES                                     | •                                    |   |   |      | •     |               | •     |
| Input Capacitance  | C <sub>iss</sub>                     | $V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,}$ $V_{DS} = -20 \text{ V}$ |   |      | 1734  |               | pF    |
| Output Capacitance   | C <sub>oss</sub>                     |   |   |      | 682   |               | 1     |
| Reverse Transfer Capacitance                                 | C <sub>rss</sub>                     | VDS2  | o v   |      | 32    |               |       |
| Total Gate Charge  | Q <sub>G(TOT)</sub>                  | V <sub>DS</sub> = -20 V,  | V <sub>GS</sub> = -4.5V                     |      | 12.5  |               | nC    |
|  |                                      | $I_{D} = -20 \text{ A}$   | V <sub>GS</sub> = -10V                      |      | 26.5  |               |       |
| Threshold Gate Charge  | Q <sub>G(TH)</sub>                   |   |   |      | 2.6   |               | nC    |
| Gate-to-Source Charge  | $Q_{GS}$                             | Vce = -10 V. Vr   | se = -20 V.                                 |      | 5.6   |               |       |
| Gate-to-Drain Charge   | $Q_{GD}$                             | $V_{GS} = -10 \text{ V}, V_{D}$ $I_{D} = -30$                         | A   |      | 3.8   |               |       |
| Plateau Voltage  | $V_{GP}$                             |   |   |      | 3.2   |               | V     |
| SWITCHING CHARACTERISTICS, VG                                | <sub>iS</sub> = <b>-4.5 V</b> (Note  | e 6)  |   |      |       |               |       |
| Turn-On Delay Time   | t <sub>d(on)</sub>                   |   |   |      | 11.5  |               | ns    |
| Rise Time  | t <sub>r</sub>                       | $V_{GS} = -4.5 \text{ V}, V_{D}$                                      | se = -20 V                                  |      | 97.4  |               |       |
| Turn-Off Delay Time  | t <sub>d(off)</sub>                  | $I_D = -30 \text{ A}, R_C$  | $_{\rm i}$ = 2.5 $\Omega$                   |      | 44.5  |               |       |
| Fall Time  | t <sub>f</sub>                       |   |   |      | 38.2  |               |       |
| DRAIN-SOURCE DIODE CHARACTEI                                 | RISTICS                              |   |   |      | •     |               | •     |
| Forward Diode Voltage  | $V_{SD}$                             | V <sub>GS</sub> = 0 V,  | $T_J = 25^{\circ}C$                         |      | -0.86 | -1.25         | V     |
|  |                                      | $I_{S} = -15 \text{ A}$   | T <sub>J</sub> = 125°C                      |      | -0.74 |               | 1     |
| Reverse Recovery Time  | t <sub>RR</sub>                      |   | 1   |      | 34.9  |               | ns    |
| Charge Time  | ta                                   | Vce = 0 V dle/dt  | = 100 A/us                                  |      | 15.8  |               | 1     |
| Discharge Time   | t <sub>b</sub>                       | $V_{GS}$ = 0 V, $dI_S/dt$ = 100 A/ $\mu$ s, $I_S$ = -10 A             |   |      | 19.1  |               | 1     |
| Reverse Recovery Charge                                      | Q <sub>RR</sub>                      |   |   |      | 16.3  | 52            | nC    |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5. Pulse Test: Pulse Width ≤ 300 µs, Duty Cycle ≤ 2%.

6. Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**



#### TYPICAL CHARACTERISTICS (continued)

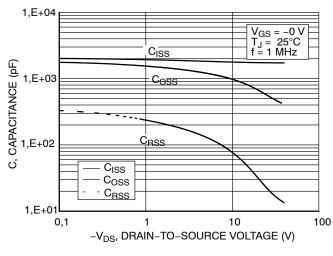
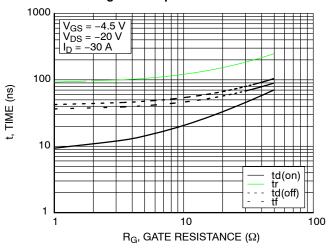


Figure 7. Capacitance Variation

Figure 8. Gate-to-Source vs. Total Charge



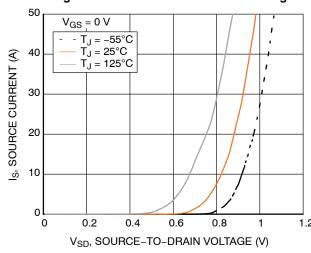
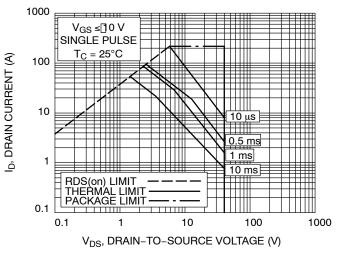


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current



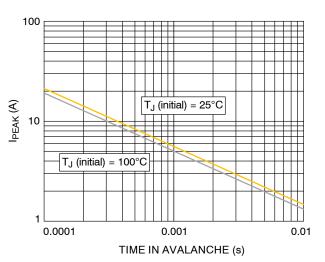


Figure 11. Maximum Rated Forward Biased Dafe operating Area

Figure 12. Maximum Drain Current vs. Time in Avalanche

# TYPICAL CHARACTERISTICS (continued)

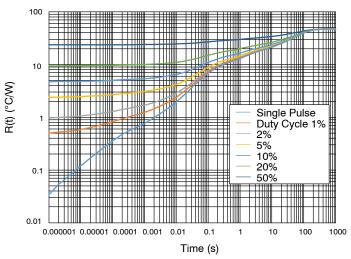


Figure 13. Thermal Response

### **DEVICE ORDERING INFORMATION**

| Device             | Marking | Package                             | Shipping <sup>†</sup> |
|--------------------|---------|-------------------------------------|-----------------------|
| NVTFS014P04M8LTAG  | 014M    | WDFN8<br>(Pb-Free)                  | 1500 / Tape & Reel    |
| NVTFWS014P04M8LTAG | 014W    | WDFNW8<br>(Pb-Free, Wettable Flank) | 1500 / Tape & Reel    |

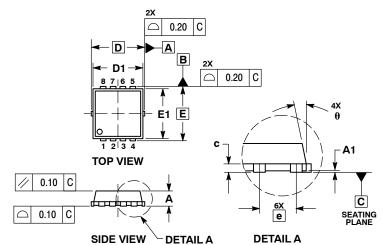
<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.





WDFN8 3.3x3.3, 0.65P CASE 511AB ISSUE D

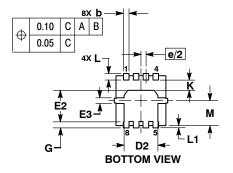
**DATE 23 APR 2012** 



#### NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
  CONTROLLING DIMENSION: MILLIMETERS.
  DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH
  PROTRUSIONS OR GATE BURRS.

|     | MILLIMETERS |          | INCHES |           |          |       |  |
|-----|-------------|----------|--------|-----------|----------|-------|--|
| DIM | MIN         | NOM      | MAX    | MIN       | NOM      | MAX   |  |
| Α   | 0.70        | 0.75     | 0.80   | 0.028     | 0.030    | 0.031 |  |
| A1  | 0.00        |          | 0.05   | 0.000     |          | 0.002 |  |
| b   | 0.23        | 0.30     | 0.40   | 0.009     | 0.012    | 0.016 |  |
| С   | 0.15        | 0.20     | 0.25   | 0.006     | 0.008    | 0.010 |  |
| D   |             | 3.30 BSC |        | 0         | .130 BSC |       |  |
| D1  | 2.95        | 3.05     | 3.15   | 0.116     | 0.120    | 0.124 |  |
| D2  | 1.98        | 2.11     | 2.24   | 0.078     | 0.083    | 0.088 |  |
| E   | 3.30 BSC    |          |        | 0.130 BSC |          |       |  |
| E1  | 2.95        | 3.05     | 3.15   | 0.116     | 0.120    | 0.124 |  |
| E2  | 1.47        | 1.60     | 1.73   | 0.058     | 0.063    | 0.068 |  |
| E3  | 0.23        | 0.30     | 0.40   | 0.009     | 0.012    | 0.016 |  |
| е   |             | 0.65 BSC | ;      | 0.026 BSC |          |       |  |
| G   | 0.30        | 0.41     | 0.51   | 0.012     | 0.016    | 0.020 |  |
| K   | 0.65        | 0.80     | 0.95   | 0.026     | 0.032    | 0.037 |  |
| L   | 0.30        | 0.43     | 0.56   | 0.012     | 0.017    | 0.022 |  |
| L1  | 0.06        | 0.13     | 0.20   | 0.002     | 0.005    | 0.008 |  |
| M   | 1.40        | 1.50     | 1.60   | 0.055     | 0.059    | 0.063 |  |
| θ   | 0 °         |          | 12 °   | 0 °       |          | 12 °  |  |

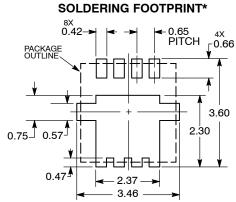


#### **GENERIC MARKING DIAGRAM\***



XXXXX = Specific Device Code Α = Assembly Location

= Year WW = Work Week = Pb-Free Package



DIMENSION: MILLIMETERS

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

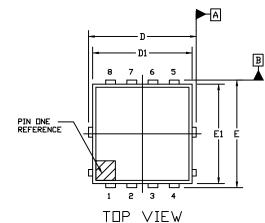
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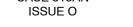
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<sup>\*</sup>This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

# WDFNW8 3.3x3.3, 0.65P (Full-Cut μ8FL WF) CASE 515AN **ISSUE O**

**DATE 25 AUG 2020** 



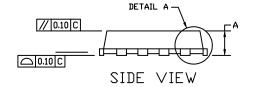


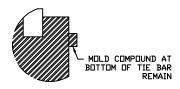
NOTES:

- 1. DIMENSIONING AND TOLERANCING PERASME Y14.5M, 2009.
- CONTROLLING DIMENSION MILLIMETERS
- DIMENSION DI AND EI DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.

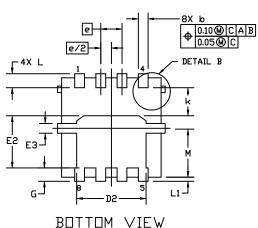
|    |        | <                 | ATED                | AREA |
|----|--------|-------------------|---------------------|------|
| A1 | DETAIL | <del>Т</del><br>А | C<br>SEATI<br>PLANE |      |

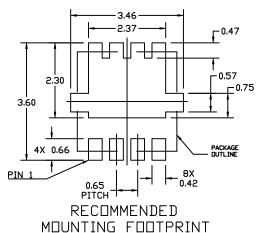
|     | MILLIMETERS |          |      |  |  |  |
|-----|-------------|----------|------|--|--|--|
| DIM | MIN.        | NDM.     | MAX. |  |  |  |
| Α   | 0.70        | 0.75     | 0.80 |  |  |  |
| A1  | 0.00        |          | 0.05 |  |  |  |
| b   | 0.23        | 0.30     | 0.40 |  |  |  |
| c   | 0.15        | 0.20     | 0.25 |  |  |  |
| D   | 3.05        | 3.30     | 3.55 |  |  |  |
| D1  | 2.95        | 3.05     | 3.15 |  |  |  |
| D2  | 1.98        | 2.11     | 2.24 |  |  |  |
| Ε   | 3.05        | 3.30     | 3.55 |  |  |  |
| E1  | 2.95        | 3.05     | 3.15 |  |  |  |
| E2  | 1.47        | 1.60     | 1.73 |  |  |  |
| E3  | 0.23        | 0.30     | 0.40 |  |  |  |
| e   |             | 0.65 BSC |      |  |  |  |
| G   | 0.30        | 0.41     | 0.51 |  |  |  |
| K   | 0.65        | 0.80     | 0.95 |  |  |  |
| L   | 0.30        | 0.43     | 0.59 |  |  |  |
| L1  | 0.06        | 0.13     | 0.20 |  |  |  |
| М   | 1.40        | 1.50     | 1.60 |  |  |  |
|     |             |          |      |  |  |  |





DETAIL B





For additional information on our Pb-Free strategy and soldering details, please download the IN Semiconductor Soldering and Mounting Techniques Reference Manual, SDLDERRM/D.

## **GENERIC MARKING DIAGRAM\***

XXXX AYWW= XXXX = Specific Device Code

= Assembly Location

= Year

WW = Work Week

= Pb-Free Package

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "=", may or may not be present. Some products may not follow the Generic Marking.

(Note: Microdot may be in either location)

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